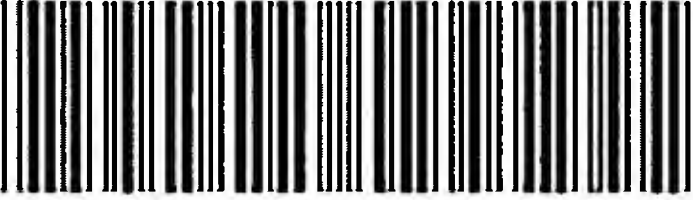


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/034,171	TENEREILLO ET AL.	
	Examiner	Art Unit	
	David Lazaro	2155	

SEARCHED			
Class	Subclass	Date	Examiner
709	203, 217-219, 239	2/1/2006	DRL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST: USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB See History	2/1/2006	DRL